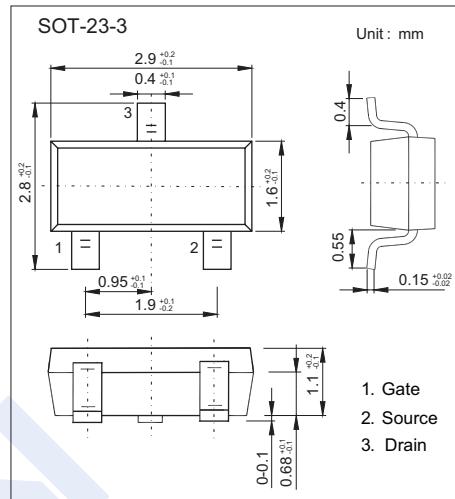
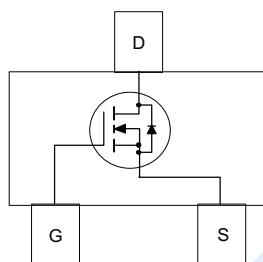


## N-Channel MOSFET

## KI3N10DS

## ■ Features

- $V_{DS} (V) = 100V$
- $I_D = 3 A$
- $R_{DS(ON)} < 160 \text{ m}\Omega$  ( $V_{GS} = 10V$ )
- $R_{DS(ON)} < 170 \text{ m}\Omega$  ( $V_{GS} = 4.5V$ )

■ Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current	$I_D$	3	A
Pulsed Drain Current (Note 1)	$I_{DM}$	20	
Power Dissipation	$P_D$	1.5	W
Thermal Resistance Junction- to-Ambient (Note 2)	$R_{thJA}$	100	$^\circ\text{C}/\text{W}$
Junction Temperature	$T_J$	150	$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-55 to 150	

## N-Channel MOSFET

## KI3N10DS

## ■ Electrical Characteristics (TA = 25°C unless otherwise noted)

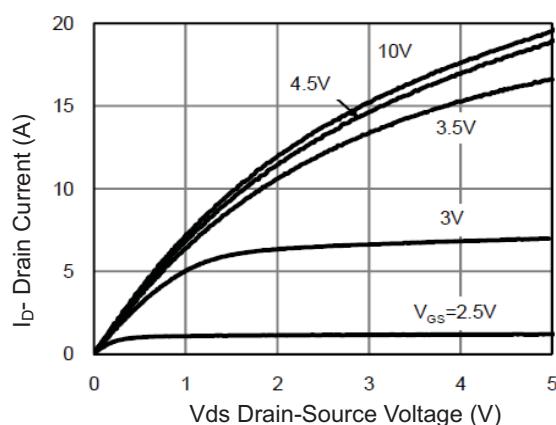
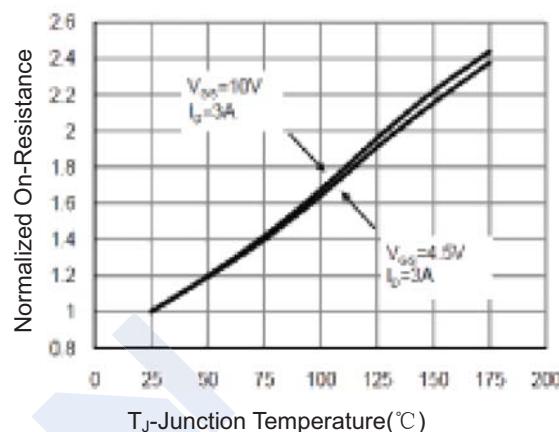
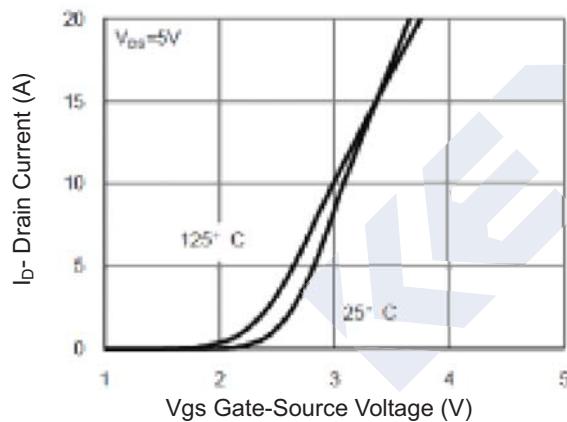
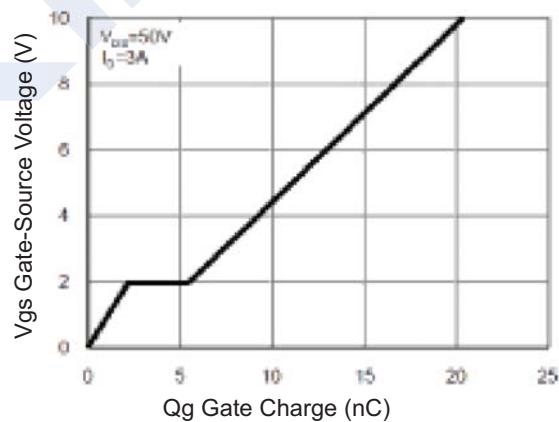
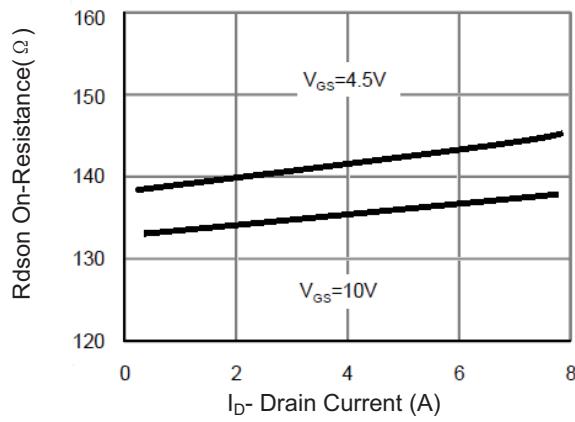
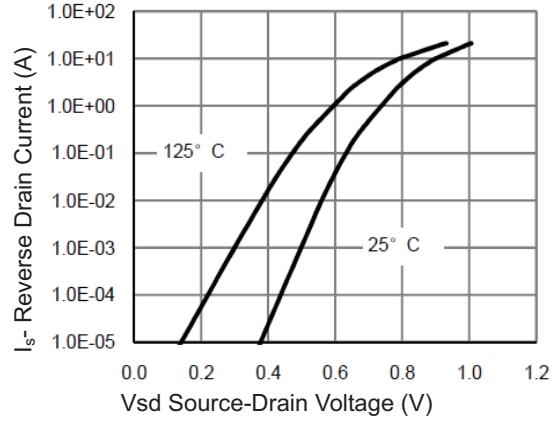
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V <sub>DSS</sub>	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	100			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>D</sub> =100V, V <sub>GS</sub> =0V			1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>D</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
Gate Threshold Voltage (Note 3)	V <sub>GS(th)</sub>	V <sub>D</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1		2	V
Static Drain-Source On-Resistance (Note 3)	R <sub>D(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =3A			160	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A			170	
Forward Transconductance (Note 3)	g <sub>FS</sub>	V <sub>D</sub> =5V, I <sub>D</sub> =3A		5		S
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>D</sub> =50V, f=1MHz (Note 4)		650		pF
Output Capacitance	C <sub>oss</sub>			24		
Reverse Transfer Capacitance	C <sub>rss</sub>			20		
Total Gate Charge	Q <sub>G</sub>	V <sub>GS</sub> =10V, V <sub>D</sub> =50V, I <sub>D</sub> =3A (Note 4)		20		nC
Gate Source Charge	Q <sub>GS</sub>			2.1		
Gate Drain Charge	Q <sub>GD</sub>			3.3		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>GS</sub> =10V, V <sub>D</sub> =50V, R <sub>L</sub> =19Ω, R <sub>G</sub> =3Ω (Note 4)		6		ns
Turn-On Rise Time	t <sub>r</sub>			4		
Turn-Off Delay Time	t <sub>d(off)</sub>			20		
Turn-Off Fall Time	t <sub>f</sub>			4		
Body-Diode Forward Current (Note 2)	I <sub>S</sub>	I <sub>S</sub> =3A, V <sub>GS</sub> =0V			3	A
Diode Forward Voltage (Note 3)	V <sub>SD</sub>				1.2	V

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2 . Surface Mounted on FR4 Board, t ≤ 10 sec.
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
4. Guaranteed by design, not subject to production.

## ■ Marking

Marking 3N10

**N-Channel MOSFET****KI3N10DS****■ Typical Characteristics and Thermal Characteristics (Curves)****Figure 1 Output Characteristics****Figure 4 Rdson-Junction Temperature****Figure 2 Transfer Characteristics****Figure 5 Gate Charge****Figure 3 Rdson-Drain Current****Figure 6 Source-Drain Diode Forward**

## N-Channel MOSFET

KI3N10DS

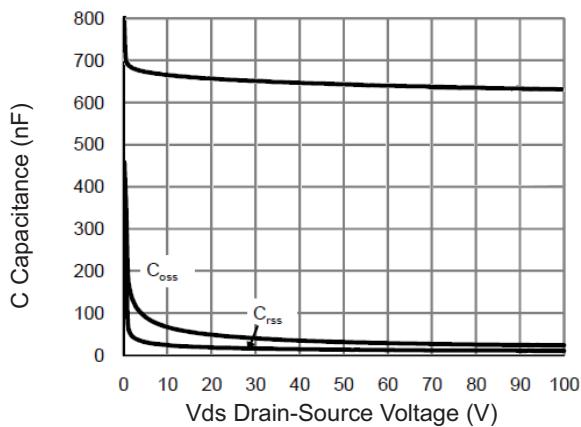


Figure 7 Capacitance vs Vds

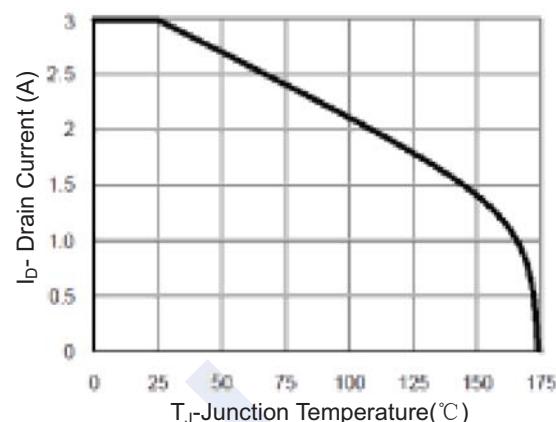
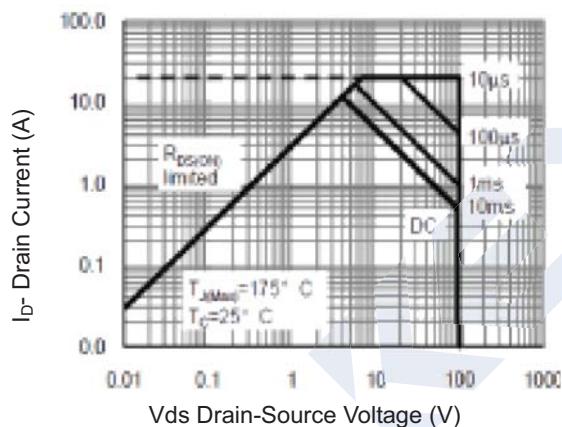
Figure 9  $BV_{DSS}$  vs Junction Temperature

Figure 8 Safe Operation Area

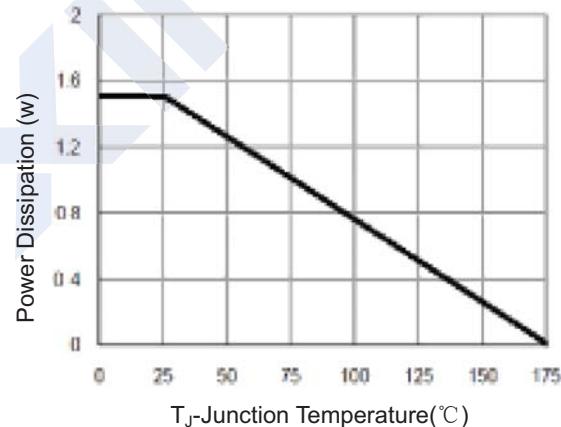


Figure 10 Power De-rating

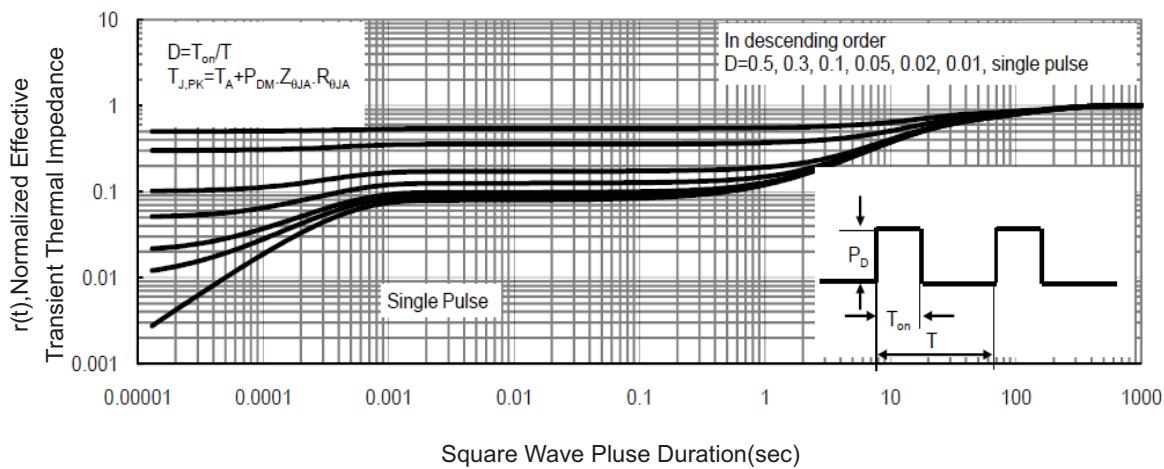


Figure 11 Normalized Maximum Transient Thermal Impedance